Transistors

Interface and switching (60V, 115mA) вк7002

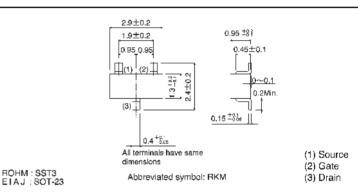
Features

- 1) Low on-resistance.
- 2) Fast switching speed.
- 3) Low-voltage drive.
- 4) Easily designed drive circuits.
- 5) Easy to parallel.

Structure

Silicon N-channel MOSFET

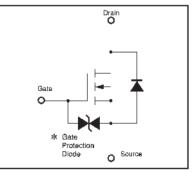




•Absolute maximum ratings (Ta = 25° C)

Parameter		Symbol	Limits	Unit
Drain-source voltage		Voss	60	V
Gate-source volt	-source voltage		±20	٧
Dura in a sura a t	Continuous	lo	115	mA
Drain current	Pulsed	DP*1	800	mA
Reverse drain current	Continuous	IDR	115	mA
	Pulsed	DRP ^{#1}	800	mA
Total power diss	ipation	Po*2	225	mW
Channel tempera	ature	Tch	150	ĩ
Storage tempera	ture	⊤stg	-55~+150	Ű

Equivalent circuit



A protection diode has been built in between the gate and the source to protect against static electricity when the product is in use. Use the protection circuit when fixed voltages are exceeded.

*1 Pw \leq 10 μ s. Duty cycle \leq 1%

*2. When mounted on a 1 \times 0.75 \times 0.062 inch glass epoxy board.

•Electrical characteristics (Ta = 25° C)

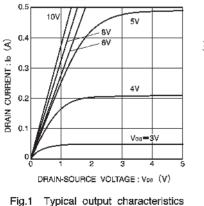
Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions
Gate-source leakage	lass	-	-	±10	μA	$V_{GS} = \pm 20 V, V_{DS} = 0 V$
Drain-source breakdown voltage	V(BR) DSS	60	_	_	ν	ID=10 µ A, VGS=0V
Zero gate voltage drain current	loss	-	-	1.0	μA	VDS=60V, VGS=0V
Gate threshold voltage	Vgs (th)	1.0	1.85	2.5	V	Vps=10V, lp=1mA
Static drain-source on-state	D *	_	_	7.5	Ω	ID=0.5A, VGS=10V
resistance	RDS (on)*	_	—	7.5		ID=0.05A, VGS=5V
Forward transfer admittance	Y _{f\$} *	80	_	_	mS	ID=0.2A, VDS=10V
Input capacitance	Ciss	_	25	50	рF	Vos=25V
Output capacitance	Coss	-	10	25	рF	Vgs=0V
Reverse transfer capacitance	Crss	-	3.0	5.0	рF	f=1MHz
Turn-on delay time	td (on) [≱]	_	12	20	ns	ID=0.2A, VDD≒30V, VGS=10V,
Turn-off delay time	ta (arr) *	_	20	30	ns	$R_L=150 \Omega$, $R_G=10 \Omega$

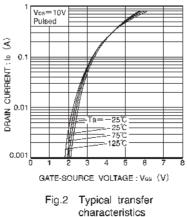
* Pw \leq 300 μ s, Duty cycle \leq 1%

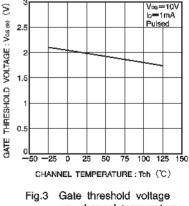
Packaging specifications

	Package	Taping
Турө	Code	T116
	Basic ordering unit (pieces)	3000
RK7002		0

Electrical characteristic curves

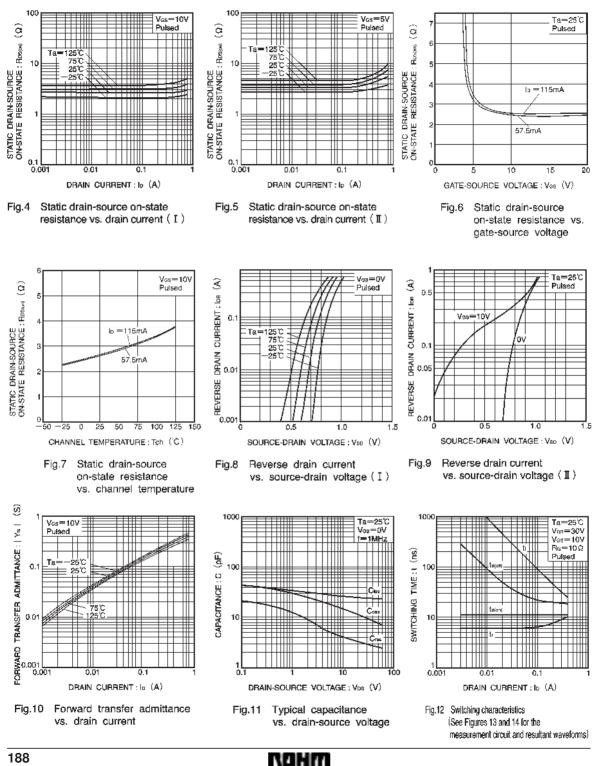






vs. channel temperature

Transistors



•Switching characteristics measurement circuit

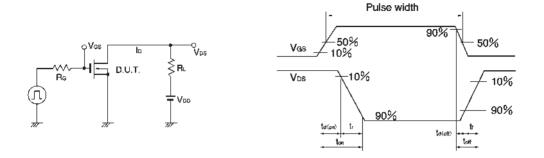


Fig.13 Switching time measurement circuit

Fig.14 Switching time waveforms

